

CY7C1011CV33

2-Mbit (128 K × 16) Static RAM

Features

- Temperature ranges
 □ Industrial: -40 °C to 85 °C
 □ Automotive-A: -40 °C to 85 °C
 □ Automotive-E: -40 °C to 125 °C
- Pin and function compatible with CY7C1011BV33
- High speed
 t_{AA} = 10 ns (Industrial and Automotive-A)
 t_{AA} = 12 ns (Automotive-E)
- Low active power
 360 mW (max) (Industrial and Automotive-A)
- 2.0 V data retention
- Automatic power down when deselected
- Independent control of upper and lower bits
- Easy memory expansion with Chip Enable (CE) and Output Enable (OE) features
- Available in Pb-free 44-pin thin small outline package (TSOP) II, 44-pin thin quad flat package (TQFP), and non Pb-free 48-ball very fine-pitch ball grid array (VFBGA) packages

Functional Description

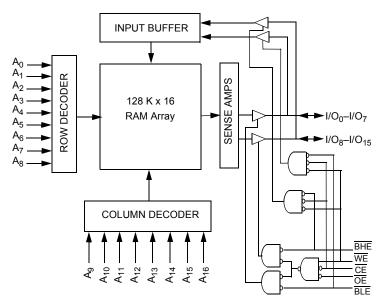
The CY7C1011CV33 is a high performance complementary metal oxide semiconductor (CMOS) static RAM organized as 131,072 words by 16 bits. This device has an automatic power down feature that significantly reduces power consumption when deselected.

To write to the device, tak<u>e</u> \overline{CE} and Write Enable (WE) inputs LOW. If Byte Low Enable (BLE) is LOW, then data from I/O pins (I/O₀ through I/O₇), is written into the location specified on the address pins (A₀ through A₁₆). If Byte High Enable (BHE) is LOW, then data from I/O pins (I/O₈ through I/O₁₅) is written into the location specified on the address pins (A₀ through A₁₆).

To read from the device, take \overline{CE} and \overline{OE} LOW while forcing the Write Enable (WE) HIGH. If BLE is LOW, then data from the memory location specified by the address pins appear on I/O₀ to I/O₇. If Byte High Enable (BHE) is LOW, then data from memory appears on I/O₈ to I/O₁₅. For more information, see the Truth Table on page 10 for a complete description of Read and Write modes.

The input and output pins (I/O₀ through I/O₁₅) are <u>placed</u> in a high impedance state when <u>the</u> device is des<u>elected</u> (CE HIGH), the outputs are disabled (\overline{OE} HIGH), the BHE and <u>BLE</u> are disabled (BHE, BLE HIGH), or during a write operation (CE LOW and WE LOW).

Logic Block Diagram





CY7C1011CV33

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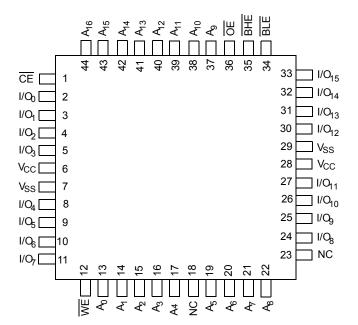


Pin Configuration

Figure 1. 44-pin TSOP II [1]

| $ \begin{array}{c} A_4 & \square & 1 \\ A_3 & \square & 2 \\ A_2 & \square & 3 \\ A_1 & \square & 4 \\ A_0 & \square & 5 \\ \hline CE & \square & 6 \end{array} $ | 44 43 42 41 40 39 | $ \begin{array}{c} A_5 \\ A_6 \\ A_7 \\ OE \\ BHE \\ BLE \\ \end{array} $ |
|---|--|--|
| $\begin{array}{c c} VO_0 & 7 \\ VO_1 & 8 \\ VO_2 & 9 \\ VO_3 & 10 \\ V_{CC} & 11 \\ V_{SS} & 12 \\ VO_4 & 13 \\ VO_5 & 14 \\ VO_6 & 15 \\ VO_7 & 16 \\ WE & 17 \end{array}$ | 37 36 35 34 33 32 31 30 29 28 | /O ₁₅ /O ₁₄ /O ₁₃ /O ₁₂ V _{SS} V _{CC} /O ₁₁ /O ₁₀ /O ₈ |
| WE L 17 A ₁₆ L 18 A ₁₅ L 19 A ₁₄ L 20 A ₁₃ L 21 A ₁₂ L 22 | 28 27 26 25 24 23 | → NC → A ₈ → A ₉ → A ₁₀ → A ₁₁ → NC |

Figure 2. 44-pin TQFP



Note 1. NC pins are not connected on the die.



Selection Guide

| Description | -10 | -12 | Unit | |
|------------------------------|--------------|-----|------|----|
| Maximum access time | | 10 | 12 | ns |
| Maximum operating current | Industrial | 100 | 95 | mA |
| | Automotive-A | 100 | - | mA |
| | Automotive-E | | | mA |
| Maximum CMOS standby current | Industrial | 10 | 10 | mA |
| | Automotive-A | 10 | - | mA |
| | Automotive-E | - | 15 | mA |



Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. These user guidelines are not tested.

| Storage temperature65 °C to +150 °C |
|---|
| Ambient temperature with power applied–55 °C to +125 °C |
| Supply voltage on V _{CC} relative to $GND^{[2]}$ –0.5 V to +4.6 V |
| DC voltage applied to outputs |
| DC voltage applied to outputs in High Z state $^{[2]}$ 0.5 V to V_{CC}+ 0.5 V |
| DC input voltage $^{[2]}$ 0.5 V to V_{CC} + 0.5 V |

| Current into outputs (LOW) | 20 mA |
|--|----------|
| Static discharge voltage (MIL-STD-883, method 3015) | > 2001 V |
| Latch up current | > 200 mA |

Operating Range

| Range | Ambient Temperature (T _A) | V _{cc} |
|---------------|--|-----------------|
| Industrial | –40 °C to +85 °C | $3.3~V\pm10\%$ |
| Automotive-A | –40 °C to +85 °C | |
| Automotive -E | –40 °C to +125 °C | |

Electrical Characteristics

Over the Operating Range

| Parameter | Description | Test Condition | - | | -10 | | -12 | Unit |
|--------------------------------------|----------------------------------|---|--------------|------|-----------------------|------|-----------------------|------|
| Parameter | Description | rest conditions | | | | Min | Max | Unit |
| V _{OH} | Output HIGH voltage | V _{CC} = Min, I _{OH} = -4.0 mA | | 2.4 | - | 2.4 | - | V |
| V _{OL} | Output LOW voltage | V _{CC} = Min, I _{OL} = 8.0 mA | | - | 0.4 | - | 0.4 | V |
| V _{IH} | Input HIGH voltage | | | 2.0 | V _{CC} + 0.3 | 2.0 | V _{CC} + 0.3 | V |
| V _{IL} | Input LOW voltage ^[2] | | | -0.3 | 0.8 | -0.3 | 0.8 | V |
| I _{IX} | Input leakage current | $GND \leq V_1 \leq V_{CC}$ | Industrial | -1 | +1 | -1 | +1 | μA |
| | | | Automotive-A | _1 | +1 | — | - | |
| | | | Automotive-E | - | - | -20 | +20 | |
| I _{OZ} Output leakage curre | Output leakage current | ut leakage current $GND \le V_1 \le V_{CC}$, Output disabled | Industrial | -1 | +1 | -1 | +1 | μA |
| | | | Automotive-A | _1 | +1 | — | - | |
| | | | Automotive-E | - | - | -20 | +20 | |
| I _{CC} | V _{CC} operating supply | V _{CC} = Max, I _{OUT} = 0 mA, | Industrial | - | 100 | - | 95 | mA |
| | current | $f = f_{MAX} = 1/t_{RC}$ | Automotive-A | - | 100 | — | - | |
| | | | Automotive-E | - | - | — | 120 | |
| I _{SB1} | Automatic CE power | Max V_{CC} , $\overline{CE} \ge V_{IH}$, | Industrial | - | 40 | — | 40 | mA |
| | down current —TTL Inputs | $V_{IN} \ge V_{IH}$ or $V_{IN} \le V_{IL}$, f = f _{MAX} | Automotive-A | - | 40 | — | - | |
| | inputs | | Automotive-E | - | - | — | 45 | |
| I _{SB2} | Automatic CE power | Max V_{CC} , $\overline{CE} \ge V_{CC} - 0.3 V$, | Industrial | - | 10 | - | 10 | mA |
| | down current — CMOS inputs | $V_{IN} \ge V_{CC} - 0.3 V$, or $V_{IN} \le 0.3 V$, f = 0 | Automotive-A | - | 10 | - | - | |
| | Inputs | $V_{\rm IN} \simeq 0.3$ V, $I = 0$ | Automotive-E | - | - | - | 15 | |



Capacitance

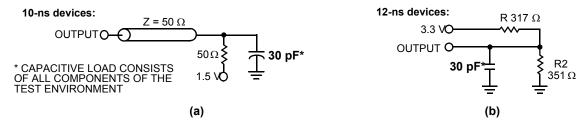
| Parameter ^[3] | Description | Test Conditions | Мах | Unit |
|--------------------------|--------------------|--|-----|------|
| C _{IN} | Input capacitance | T _A = 25 °C, f = 1 MHz, V _{CC} = 3.3 V | 8 | pF |
| C _{OUT} | Output capacitance | | 8 | pF |

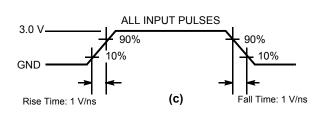
Thermal Resistance

| Parameter ^[3] | Description | Test Conditions | 44-pin TSOP II | 44-pin TQFP | Unit |
|--------------------------|--|--|----------------|-------------|------|
| Θ_{JA} | | Still air, soldered on a 3 × 4.5 inch, four-layer printed circuit board | 44.56 | 42.66 | °C/W |
| Θ_{JC} | Thermal resistance (Junction to case) | | 10.75 | 14.64 | °C/W |

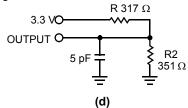
AC Test Loads and Waveforms

Figure 3. AC Test Loads and Waveforms ^[4]









Notes

- 3. Tested initially and after any design or process changes that may affect these parameters.
- AC characteristics (except High Z) for 10-ns parts are tested using the load conditions shown in Figure 3 (a). All other speeds are tested using the Thevenin load shown in Figure 3 (b). High Z characteristics are tested for all speeds using the test load shown in Figure 3 (d).



Switching Characteristics

Over the Operating Range

| Parameter [5] | B | | - | 10 | -1 | 2 | Unit |
|-----------------------------------|--|-------------------------|-----|-----|-----|-----|------|
| | Description | י - | Min | Max | Min | Мах | Unit |
| Read Cycle | • | | | | • | | |
| t _{power} ^[6] | V_{CC} (typical) to the first access | | 1 | - | 1 | - | μS |
| t _{RC} | Read cycle time | | 10 | _ | 12 | - | ns |
| t _{AA} | Address to data valid | | _ | 10 | - | 12 | ns |
| t _{OHA} | Data hold from address change | 3 | _ | 3 | - | ns | |
| t _{ACE} | CE LOW to data valid | _ | 10 | - | 12 | ns | |
| t _{DOE} | OE LOW to data valid | Industrial/Automotive-A | _ | 5 | - | 6 | ns |
| | | Automotive-E | _ | - | - | 8 | |
| t _{LZOE} | OE LOW to Low Z ^[7] | 0 | - | 0 | - | ns | |
| t _{HZOE} | OE HIGH to High Z ^[7, 8] | _ | 5 | - | 6 | ns | |
| t _{LZCE} | CE LOW to Low Z ^[7] | 3 | - | 3 | - | ns | |
| t _{HZCE} | CE HIGH to High Z ^[7, 8] | _ | 5 | - | 6 | ns | |
| t _{PU} | CE LOW to power up | 0 | - | 0 | - | ns | |
| t _{PD} | CE HIGH to power down | | _ | 10 | _ | 12 | ns |
| t _{DBE} | Byte enable to data valid | Industrial/Automotive-A | _ | 5 | _ | 6 | ns |
| | | Automotive-E | _ | _ | _ | 8 | |
| t _{LZBE} | Byte enable to Low Z | | 0 | _ | 0 | - | ns |
| t _{HZBE} | Byte disable to High Z | | _ | 5 | _ | 6 | ns |
| Write Cycle ^{[§} | 9, 10] | | | | | | • |
| t _{WC} | Write cycle time | | 10 | _ | 12 | _ | ns |
| t _{SCE} | CE LOW to write end | | 7 | _ | 8 | - | ns |
| t _{AW} | Address setup to write end | | 7 | _ | 8 | - | ns |
| t _{HA} | Address hold from write end | | 0 | - | 0 | - | ns |
| t _{SA} | Address setup to write start | | 0 | _ | 0 | - | ns |
| t _{PWE} | WE pulse width | | 7 | _ | 8 | - | ns |
| t _{SD} | Data setup to write end | | 5 | _ | 6 | - | ns |
| t _{HD} | Data hold from write end | | 0 | - | 0 | _ | ns |
| t _{LZWE} | WE HIGH to Low Z ^[7] | | 3 | _ | 3 | - | ns |
| t _{HZWE} | WE LOW to High Z ^[7, 8] | | _ | 5 | _ | 6 | ns |
| t _{BW} | Byte enable to end of write | | 7 | - | 8 | - | ns |

Notes

5. Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, and input pulse levels of 0 to 3.0 V.
6. t_{POWER} gives the minimum amount of time that the power supply is at typical V_{CC} values until the first memory access is performed.
7. At any temperature and voltage condition, t_{HZCE} is less than t_{LZCE}, t_{HZDE} is less than t_{LZCE}, and t_{HZWE} for any device.
8. t_{HZOE}, t_{HZBE}, t_{HZCE}, and t_{HZWE} are specified with a load capacitance of 5 pF as in part (d) of Figure 3 on page 6. Transition is measured ±500 mV from steady state voltage
9. The internal write time of the memory is defined by the overlap of CE LOW, WE LOW, and BHE/BLE LOW. CE, WE, and BHE/BLE must be LOW to initiate a write. The transition of these signals terminate the write. The input data setup and hold timing is referenced to the leading edge of the signal that terminates the write.
10. The minimum write cycle time for Write Cycle No. 3 (WE controlled, OE LOW) is the sum of t_{HZWE} and t_{SD}.



Switching Waveforms

Figure 4. Read Cycle No. 1 (Address Transition Controlled) ^[11, 12]

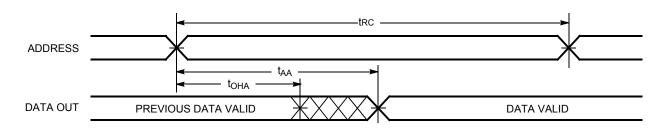
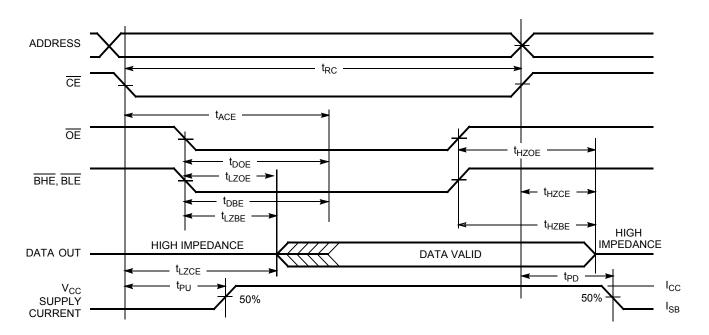


Figure 5. Read Cycle No. 2 (OE Controlled) ^[12, 13]



Notes

11. <u>Device</u> is continuously selected. \overline{OE} , \overline{CE} , \overline{BHE} , and/or $\overline{BLE} = V_{IL}$. 12. WE is HIGH for read cycle. 13. Address valid prior to or coincident with \overline{CE} transition LOW.



Switching Waveforms (continued)

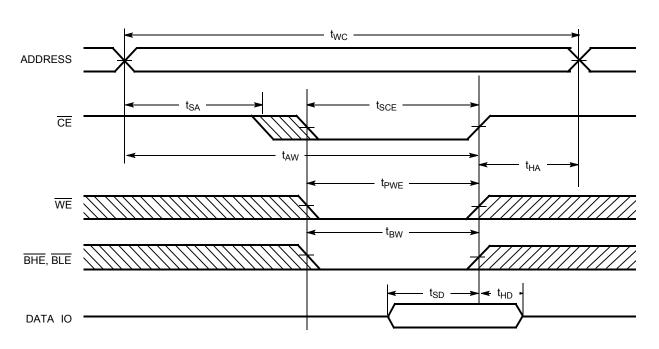
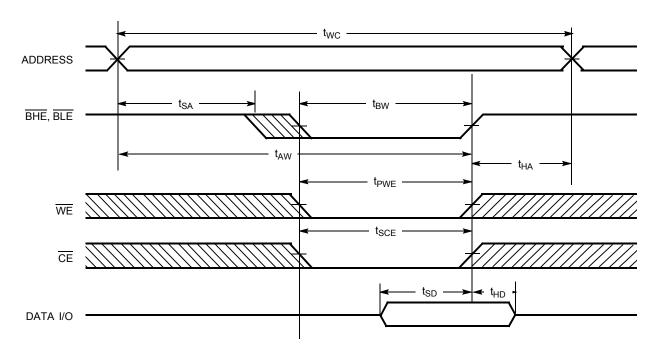


Figure 6. Write Cycle No. 1 (CE Controlled) ^[14, 15]

Figure 7. Write Cycle No. 2 (BLE or BHE Controlled)



Notes

Data I/O is high impedance if OE, BHE, and/or BLE = V_{IH}.
 If CE goes HIGH simultaneously with WE going HIGH, the output remains in a high impedance state.



Switching Waveforms (continued)

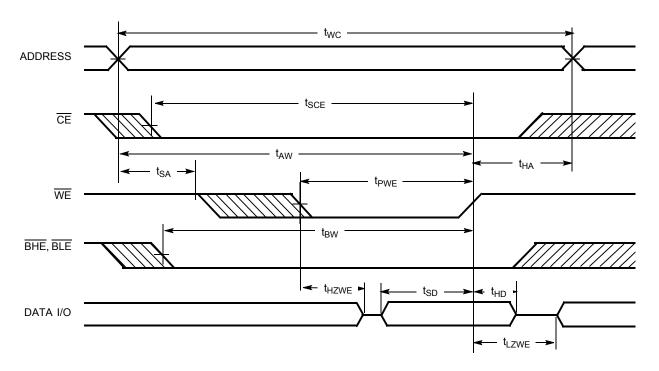


Figure 8. Write Cycle No. 3 (WE Controlled, LOW)

Truth Table

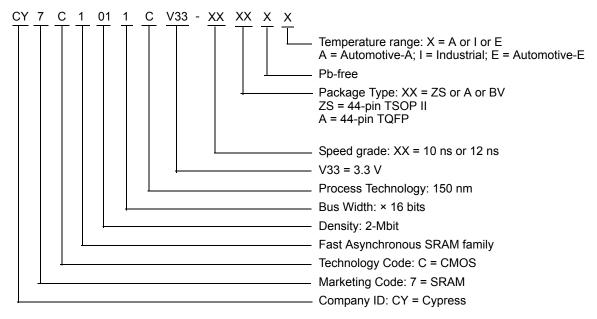
| CE | OE | WE | BLE | BHE | I/O ₀ –I/O ₇ | I/O ₈ –I/O ₁₅ | Mode | Power |
|----|----|----|-----|-----|------------------------------------|-------------------------------------|----------------------------|----------------------------|
| Н | Х | Х | Х | Х | High Z | High Z | Power down | Standby (I _{SB}) |
| L | L | Н | L | L | Data Out | Data Out | Read – all bits | Active (I _{CC}) |
| L | L | Н | L | Н | Data Out | High Z | Read – lower bits only | Active (I _{CC}) |
| L | L | Н | Н | L | High Z | Data Out | Read – upper bits only | Active (I _{CC}) |
| L | Х | L | L | L | Data In | Data In | Write – all bits | Active (I _{CC}) |
| L | Х | L | L | Н | Data In | High Z | Write – lower bits only | Active (I _{CC}) |
| L | Х | L | Н | L | High Z | Data In | Write – upper bits only | Active (I _{CC}) |
| L | Н | Н | Х | Х | High Z | High Z | Selected, outputs disabled | Active (I _{CC}) |



Ordering Information

| Speed (ns) | Ordering Code | Package Diagram | Package Type | Operating Range |
|---------------|---------------------|--------------------|--------------------------|--------------------|
| 10 | CY7C1011CV33-10ZSXA | 51-85087 | 44-pin TSOP II (Pb-free) | Automotive-A |
| 12 | CY7C1011CV33-12ZSXE | 51-85087 | 44-pin TSOP II (Pb-free) | Automotive-E |

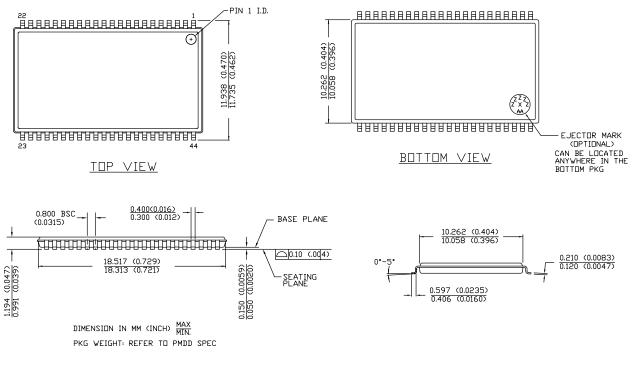
Ordering Code Definitions





Package Diagrams

Figure 9. 44-pin TSOP Z44-II, 51-85087

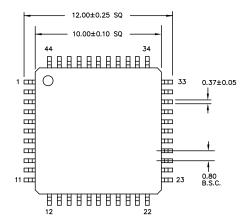


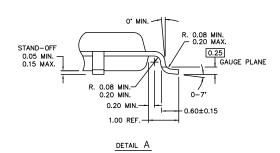
51-85087 *E



Package Diagrams (continued)

Figure 10. 44-pin TQFP (10 × 10 × 1.4 mm) A44S, 51-85064





NOTE:

- SEATING PLANE 1.60 MAX. 1.60 MAX. 1.60 MAX. 1.40±0.05 0.20 MAX. SEE DETAIL A
- NOTE.
- 1. JEDEC STD REF MS-026
- 2. BODY LENGTH DIMENSION DOES NOT INCLUDE MOLD PROTRUSION/END FLASH MOLD PROTRUSION/END FLASH SHALL NOT EXCEED 0.0098 in (0.25 mm) PER SIDE BODY LENGTH DIMENSIONS ARE MAX PLASTIC BODY SIZE INCLUDING MOLD MISMATCH
- 3. DIMENSIONS IN MILLIMETERS

51-85064 *E





Acronyms

| Acronym | Description | | | |
|---------|---|--|--|--|
| BHE | byte high enable | | | |
| BLE | byte low enable | | | |
| CMOS | complementary metal oxide semiconductor | | | |
| CE | chip enable | | | |
| I/O | input/output | | | |
| OE | output enable | | | |
| SRAM | static random access memory | | | |
| TQFP | thin quad flat pack | | | |
| TSOP | thin small outline package | | | |
| TTL | transistor-transistor logic | | | |
| VFBGA | very fine-pitch ball gird array | | | |
| WE | write enable | | | |

Document Conventions

Units of Measure

| Symbol | Unit of Measure |
|--------|-----------------|
| °C | degree Celsius |
| MHz | megahertz |
| μA | microampere |
| μs | microsecond |
| mA | milliampere |
| mm | millimeter |
| ms | millisecond |
| mV | millivolt |
| mW | milliwatt |
| ns | nanosecond |
| % | percent |
| pF | pico farad |
| V | volt |
| W | watt |





Document History Page

Document Title: CY7C1011CV33, 2-Mbit (128 K × 16) Static RAM Document Number: 38-05232

| Revision | ECN | Orig. of Change | Submission Date | Description of Change |
|----------|---------|--------------------|--------------------|---|
| ** | 117132 | HGK | 07/31/02 | New Data Sheet |
| *A | 118057 | HGK | 08/19/02 | Pin configuration for 48-ball FBGA correction |
| *B | 119702 | DFP | 10/11/02 | Updated FBGA to VFBGA; updated package code on page 8 to BV48A. Updated address pinouts on page 1 to A0 to A16. Updated CMOS standby current on page 1 from 8 to 10 mA |
| *C | 386106 | PCI | See ECN | Added lead-free parts in Ordering Information Table |
| *D | 498501 | NXR | See ECN | Corrected typo in the Logic Block Diagram on page# 1 Included the Maximum Ratings for Static Discharge Voltage and Latch up Current on page# 3 Changed the description of I _{IX} from Input Load Current to Input Leakage Current in DC Electrical Characteristics table Updated the Ordering Information Table |
| *E | 522620 | VKN | See ECN | Added Thermal Resistance Table |
| *F | 1891366 | VKN/AESA | See ECN | Added -10ZSXA part Updated Ordering Information table |
| *G | 2428606 | VKN/PYRS | See ECN | Corrected typo in the 44-Pin TSOP and 48-Ball FBGA pinout Removed Commercial parts Removed 15 ns speed bin Removed inactive parts from the Ordering Information table |
| *H | 2664421 | VKN/AESA | 02/25/09 | Added Automotive-E specs for 12 ns speed Updated Ordering Information table |
| * | 2898399 | KAO/AJU | 03/24/2010 | Updated Package Diagrams |
| *J | 2950666 | VKN | 06/11/2010 | Included "CY7C1011CV33-12BVXE" in Ordering Information Added Contents and Acronyms Updated Sales, Solutions, and Legal Information Added Ordering Code Definitions. |
| *K | 3089939 | PRAS | 11/13/2010 | Removed inactive part from Ordering Information. |
| *L | 3276463 | KAO | 06/07/2011 | Updated Functional Description (Removed "For best practice recommendations, refer to the Cypress application note AN1064, SRAM System Guidelines."). Added Units of Measure. Updated Package Diagrams. Updated in new template. |
| *M | 3591978 | TAVA | 04/19/2012 | Removed all information related to 48-ball VFBGA throughout the document. Updated package diagram revisions. |
| *N | 3861271 | KAO | 01/08/2013 | Updated Ordering Information (Updated part numbers). |
| | | | | Updated Package Diagrams: spec 51-85087 – Changed revision from *D to *E. |



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